
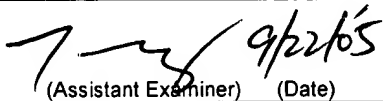




Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/836,480	MIYANO, KAZUTAKA	
	Examiner	Art Unit	
	Ted M. Wang	2634	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
375		376			375	375	373	327	
INTERNATIONAL CLASSIFICATION					327	102	147	159	
H	0	3	D	3/24	331	1R			
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 (Assistant Examiner) (Date)		 STEPHEN CHIN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)		Total Claims Allowed: 5	
 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 8

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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